



<b>Search Notes</b>  	Application/Control No.  10790001	Applicant(s)/Patent Under Reexamination  NAKAMURA ET AL.
	Examiner Mackey, Patrick H	Art Unit 3651

Notes	Date	Examiner
Text Search (USPGPUB, USPAT, EPO, JPO, Derwent)	10/28/05	phm
Plus Search	10/28/05	phm


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<b><i>Interference Searched</i></b>  	Application/Control No.  10790001	Applicant(s)/Patent Under Reexamination  NAKAMURA ET AL.
	Examiner Mackey, Patrick H	Art Unit 3651

Class	SubClass	Date	Examiner
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See	Printout	7/13/06	phm
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<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10790001</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>NAKAMURA ET AL.</p>
	<p>Examiner</p> <p>Mackey, Patrick H</p>	<p>Art Unit</p> <p>3651</p>

Class	SubClass	Date	Examiner
270	58.01		
	59		
	58.08		
	59		
	58.11		
	58.12		
	58.14		
	58.16		
	58.17		
	58.18		
	58.27		
399	410		
271	189	10/28/05	phm
Updated	Search	4/19/06	phm
Updated	Search	7/13/06	phm
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